MOSFET - Power, Single N-Channel, D²PAK7

150 V, 7 mΩ, 121 A

NTBGS6D5N15MC

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

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Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	150	V
Gate-to-Source Voltage			V _{GS}	±20	V
$\begin{array}{l} \text{Continuous Drain} \\ \text{Current } R_{\theta JC} \\ \text{(Note 2)} \end{array}$	Steady State T _C = 25°C		۱ _D	121	A
Power Dissipation $R_{\theta JC}$ (Note 2)			P _D	238	W
Continuous Drain Current R _{θJA} (Notes 1, 2)	Steady State	T _A = 25°C	۱ _D	15	A
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)			PD	3.7	W
Pulsed Drain Current	$T_{A} = 25^{\circ}$	°C, t _p = 10 μs	I _{DM}	1800	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			IS	198	А
Single Pulse Drain-to-Source Avalanche Energy (I _L = 60 A _{pk} , L = 0.1 mH)			E _{AS}	180	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using a 1 in², 1 oz. Cu pad.

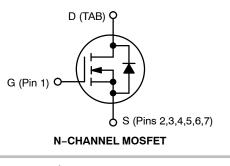
2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
150 V	7 mΩ @ 10 V	121 A
	8.7 mΩ @ 8 V	





ORDERING INFORMATION

Device	Package	Shipping [†]
NTBGS6D5N15MC	D ² PAK7 (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ extsf{ heta}JC}$	0.6	°C/W
Junction-to-Ambient - Steady State (Note 1, 2)	$R_{ hetaJA}$	40	

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		150			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J	$I_D = 250 \ \mu\text{A}$, ref to 25°C			59.62		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1	μA
		V _{DS} = 120 V	T _J = 125°C			10	μA
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20$	V			±100	nA
ON CHARACTERISTICS (Note 3)					-	-	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 379$	μA	2.5	3.5	4.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 250 μA, ref to 25	°C		-9.53		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 69 A	1		5.5	7	mΩ
		V _{GS} = 8 V, I _D = 34 A			5.9	8.7	
Forward Transconductance	9 FS	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 60.5 \text{ A}$	ł		88		S
Gate-Resistance	R _G	$T_A = 25^{\circ}C$			1.1		Ω
CHARGES & CAPACITANCES	•	•					
Input Capacitance	C _{ISS}	V_{GS} = 0 V, V_{DS} = 75 V, f = 1 MHz			4745		pF
Output Capacitance	C _{OSS}				1370		1
Reverse Transfer Capacitance	C _{RSS}				10.3		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 75 V, I _D = 69 A V _{GS} = 10 V, V _{DS} = 75 V			57		nC
Threshold Gate Charge	Q _{G(TH)}				16		
Gate-to-Source Charge	Q _{GS}				27		
Gate-to-Drain Charge	Q _{GD}				7		
Output Charge	Q _{OSS}				171		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn–On Delay Time	t _{d(ON)}	V _{GS} = 10 V, V _{DS} = 75	V,		34		ns
Rise Time	tr	I _D = 69 A, R _G = 6 Ω			75		
Turn-Off Delay Time	t _{d(OFF)}				39		
Fall Time	t _f				6		
DRAIN-SOURCE DIODE CHARACTERISTIC	S	•			-		
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.92	1.2	V
		$I_{\rm S} = 69 {\rm A}$ $T_{\rm J} = 125^{\circ}{\rm C}$			0.82		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 69 A			74		ns
Charge Time	t _a				53		
Discharge Time	t _b				22		1
	-				1		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

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nC

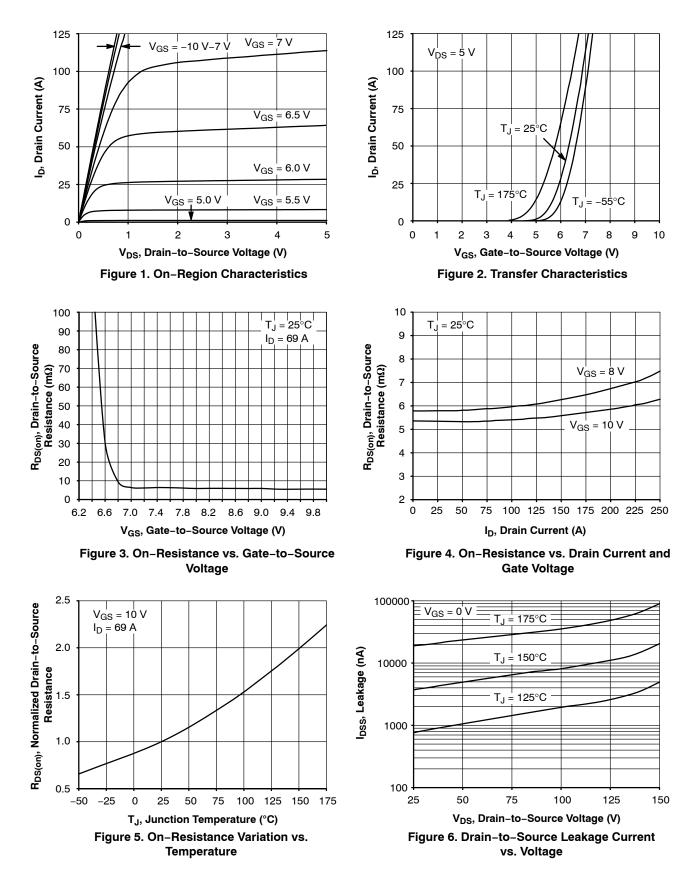
3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

Reverse Recovery Charge

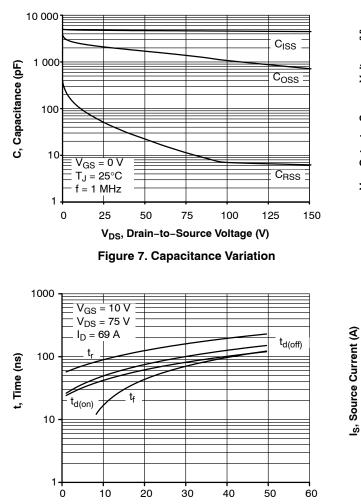
4. Switching characteristics are independent of operating junction temperatures.

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TYPICAL CHARACTERISTICS

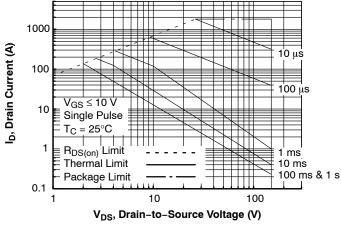


TYPICAL CHARACTERISTICS (Continued)



R_G, Gate Resistance (Ω)

Figure 9. Resistive Switching Time Variation vs. Gate Resistance





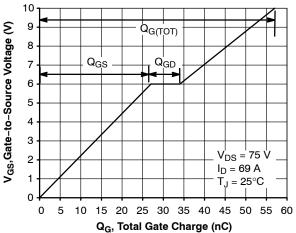


Figure 8. Gate-to-Source vs. Total Charge

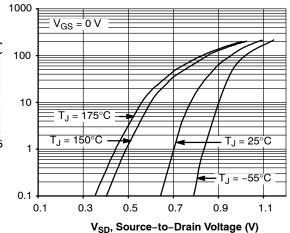
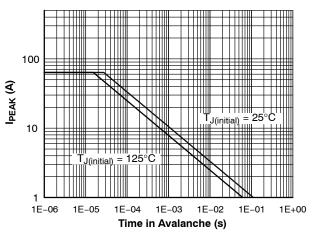
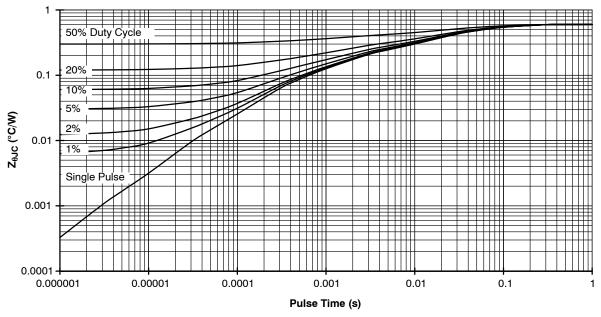


Figure 10. Diode Forward Voltage vs. Current





TYPICAL CHARACTERISTICS (Continued)



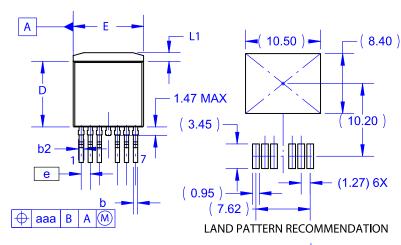


PACKAGE DIMENSIONS

D²PAK7 (TO-263 7 LD) CASE 418AY ISSUE C

- A

А



В

c2

Ĥ

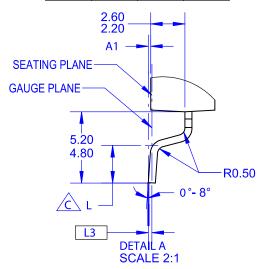
С

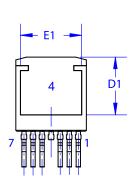
NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE. D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994. E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS. F. LAND PATTERN RECOMMENDATION PER IPC. TO127P1524X465-8N.

DIM	MILLIMETERS					
	MIN		MAX			
A	4.30	4.50	4.70			
A1	0.00	0.10	0.20			
b2	0.70	0.80	0.90			
b	0.50	0.60	0.70			
С	0.40	0.50	0.60			
c2	1.20	1.30	1.40			
D	9.00	9.20	9.40			
D1	7.70	~	~			
E	9.70	9.90	10.20			
E1	8.38	8.58	8.78			
е	~	1.27	~			
Н	15.10	15.40	15.70			
L	2.44	2.64	2.84			
L1	1.00	1.20	1.40			
L3	~	0.25	~			
aaa	~	~	0.25			







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